

# N-Channel 30 V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)		
30	0.0094 at $V_{GS} = 10 \text{ V}$	13.7		
	0.0107 at V <sub>GS</sub> = 4.5 V	13.7		

#### **FEATURES**

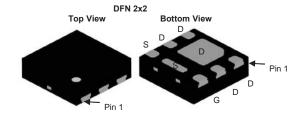
- DT-Trench Power MOSFET
- Ultra Small DFN2X2 Chipscale Packaging Reduces Footprint Area

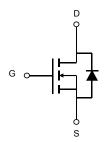


RoHS

#### **APPLICATIONS**

- DC/DC Converters in Computing, Servers, and POL
- Isolated DC/DC Converters in Telecom and Industrial





Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	30	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v	
	T <sub>C</sub> = 25 °C		13.7 <sup>a</sup>		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	l I <sub>D</sub>	11 <sup>a</sup>		
Continuous Brain Carrent (1) = 100 °C)	T <sub>A</sub> = 25 °C	J '0 [	10 <sup>a, b, c</sup>		
	T <sub>A</sub> = 70 °C	1 -	5 <sup>b, c</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	55		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C		10 <sup>a</sup>		
Continuous Source-Diam Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	4.5 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		16		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	10	w	
Maximum Fower Dissipation	T <sub>A</sub> = 25 °C	1 '0	2.5 <sup>b, c</sup>	VV	
	T <sub>A</sub> = 70 °C	1	0.7 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) <sup>d, e</sup>			260		

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 5 s	R <sub>thJA</sub>	35	50	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	5.8	8.1	O/VV		

#### Notes:

- a. Package limited
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. The DFN2X2 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 80 °C/W.



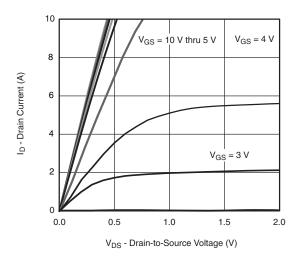
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$				V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	<sub>S</sub> /T <sub>J</sub> I <sub>D</sub> = 250 μA		24		m\//°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	10 – 200 μπ		- 5.6		mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_{D} = 250 \mu A$	0.5		1.5	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 5	μΑ
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			1	
		V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10	μΑ
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	25			Α
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A		0.0094	0.013	Ω
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 5 A		0.0107	0.015	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 24 V, I <sub>D</sub> = 7 A		35		S
Dynamic <sup>b</sup>	•					l
Input Capacitance	C <sub>iss</sub>			1010		pF
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		320		
Reverse Transfer Capacitance	C <sub>rss</sub>			90		
· ·	100	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A		9	18	
Total Gate Charge	$Q_g$			5	10	nC
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 24 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 5 \text{ A}$		2		
Gate-Drain Charge	Q <sub>gd</sub>			1.7		
Gate Resistance	R <sub>g</sub>	f = 1 MHz		2.9		Ω
Turn-On Delay Time	t <sub>d(on)</sub>			16		
Rise Time	t <sub>r</sub>	V 04V D 40		10		- ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{DD} = 24 \text{ V}, R_L = 1 \Omega$ $I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_q = 1 \Omega$		15		
Fall Time	t <sub>f</sub>	ID = IOA, VGEN - IOV, IIg - IS2		10		
Turn-On Delay Time	t <sub>d(on)</sub>			10		
Rise Time	t <sub>r</sub>	V - 24 V B - 1 O		8		
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{DD} = 24 \text{ V}, R_L = 1 \Omega$ $I_D \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_q = 1 \Omega$		17		
Fall Time	t <sub>f</sub>	10 = 07, VGEN = 1.3 1, 1.1g = 1.22		8		
Drain-Source Body Diode Characteristic	s				L	L
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			10	
Pulse Diode Forward Current	I <sub>SM</sub>				40	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A, V <sub>GS</sub> = 0 V		0.8	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			18	30	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1 10 A dl/dt 100 A/v- T 05 00		7	15	nC
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		8		
Reverse Recovery Rise Time	t <sub>b</sub>	_		10		ns

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

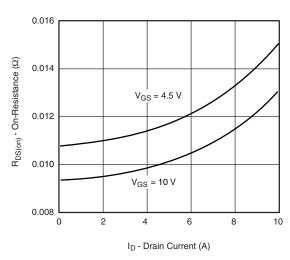
Notes: a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.



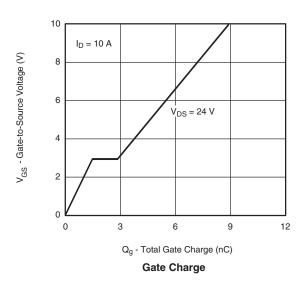
# TYPICAL CHARACTERISTIC (25 °C, unless otherwise noted)

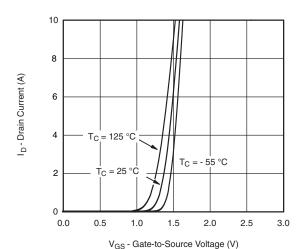


### **Output Characteristics**

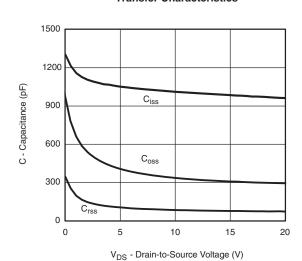


On-Resistance vs. Drain Current and Gate Voltage

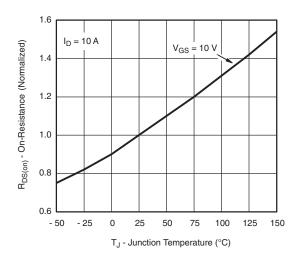




Transfer Characteristics



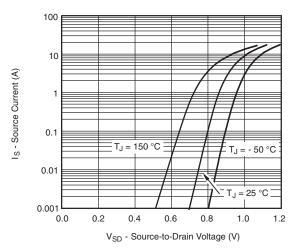
Capacitance



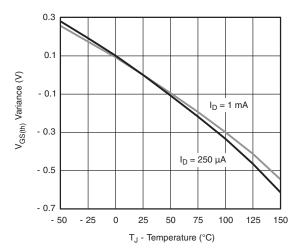
On-Resistance vs. Junction Temperature



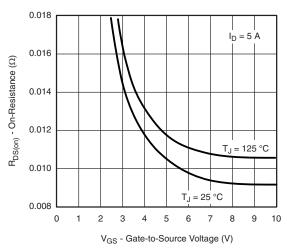
## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



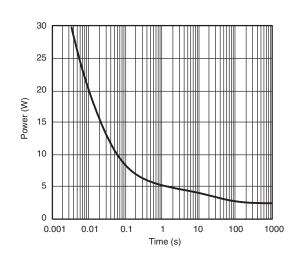
### Source-Drain Diode Forward Voltage



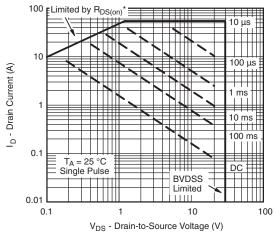
**Threshold Voltage** 



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power (Junction-to-Ambient)

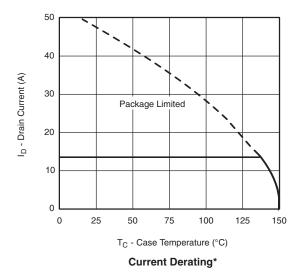


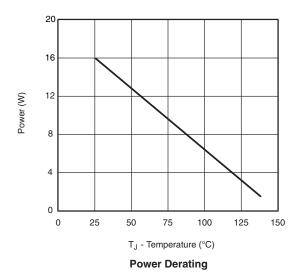
\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area, Junction-to-Ambient



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

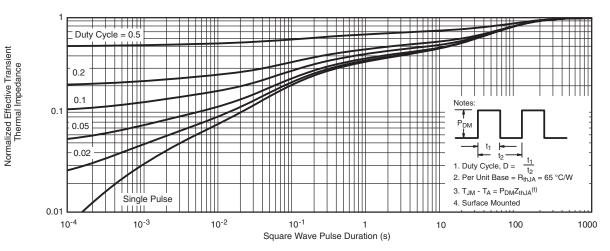




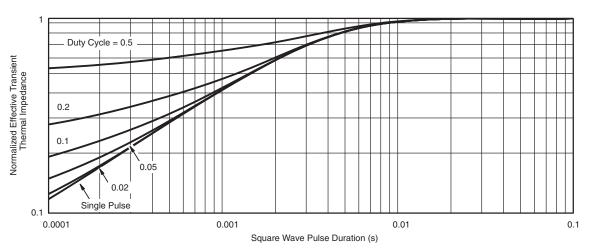
 $<sup>^{\</sup>star}$  The power dissipation  $P_D$  is based on  $T_{J(max.)}$  = 150  $^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



# TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



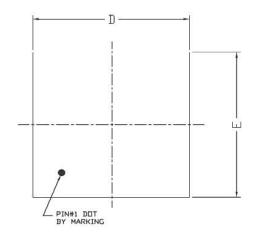
Normalized Thermal Transient Impedance, Junction-to-Ambient

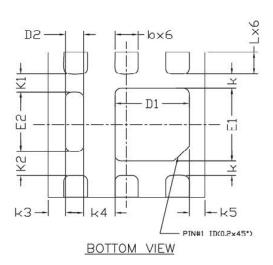


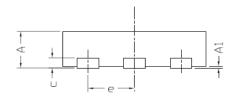
Normalized Thermal Transient Impedance, Junction-to-Case



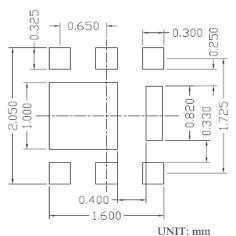
# DFN2x2 \_6L\_EP1\_S PACKAGE OUTLINE







# RECOMMENDED LAND PATTERN



SYMBOLS	DIMENSIONS IN MILLIMETERS		DIMENSIONS IN INCHES			
SIMBOLS	MIN	NOM	MAX	MIN	NOM	MAX
A	0.50	0. 55	0.60	0.020	0.022	0.024
A1	0.00		0.05	0.000		0.002
ь	0.25	0.30	0.35	0.010	0.012	0.014
С	0. 152 REF			0.006 REF		
D	1.90	2.00	2.10	0.075	0.079	0.083
D1	0.85	0.95	1.05	0.033	0.037	0.041
D2	0.13	0.23	0.33	0.005	0.009	0.013
E	1.90	2.00	2.10	0.075	0.079	0.083
E1	0.90	1.00	1.10	0.035	0.039	0.043
E2	0.72	0.82	0.92	0.028	0.032	0.036
e	0.65 BSC			0. 026 BSC		
K	0. 20 BSC			0.008 BSC		
K1	0. 25 BSC			0.010 BSC		
K2	0. 33 BSC			0.013 BSC		
K3	0. 22 BSC			0.009 BSC		
K4	0.40 BSC			0. 016 BSC		
K5	0. 20 BSC			0.008 BSC		
L	0.25	0.30	0.35	0.010	0.012	0.014

#### NOTE

CONTROLLING DIMENSION IS MILLIMETER.
CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.





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